







NOTES/SPECIFICATIONS:

- CLEAR APERTURE: > Ø21.6 mm SURFACE QUALITY (\$1): 10-5 SCRATCH-DIG SURFACE FLATNESS (\$1): \(\lambda\)/10 AT 633 nm (\$2): FINE GRIND

- PARALLELISM: ≤ 3 arcmin

PARALLELISM: \$ 3 Grcmin
THICKNESS TOLERANCE: ±0.2 mm
DIAMETER TOLERANCE: ±0.0/-0.1 mm
DESIGN WAVELENGTH RANGE: 350-400 nm
COATING: BROADBAND HR, DIELECTRIC
Rs avg: >99% FROM 350-400 nm
Rp avg: >99% FROM 350-400 nm
AOI: 0° TO 45°
DAMA GE THEESHOLD: 1 1/cm² 10 ps PUISE

DAMAGE THRESHOLD: 1 J/cm² 10 ns PULSE, 10 Hz AT 355 nm

FOR INFORMATION ONLY NOT FOR MANUFACTURING PURPOSES

	DRAWING PROJECTION			THORLABS www.thorlabs.com		
		NAME	DATE	Ø 25.4 mm BROADBAND MIRROR 350-400 nm MATERIAL FUSED SILICA		R
	DRAWN	BAG	25/OCT/10			
	APPROVAL	BW	04/NOV/21			REV
	COPYRIGHT © 2021 BY THORLABS			LOSED SILICA		E
	VALUES IN PARENTHESIS ARE CALCULATED AND MAY CONTAIN ROUNDOFF ERRORS			BB1-E01	APPROX WE	:IGHT